

<b>Notice of References Cited</b>	Application/Control No. 10/623,522	Applicant(s)/Patent Under Reexamination YAMASHITA ET AL.	
	Examiner John L. Goodrow	Art Unit 1756	Page 1 of 1

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	B	US-6,824,945	11-2004	Emoto et al.	430/137.15
	C	US-5,429,901	07-1995	Muto et al.	430/108.11
	D	US-5,368,972	11-1994	Yamashita et al.	430/137.11
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	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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